

mos field effect transistor $\mu PA572T$

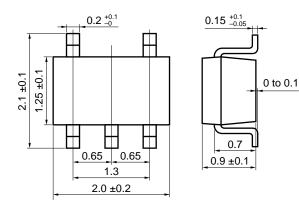
N-CHANNEL MOS FET (5-PIN 2 CIRCUITS) FOR SWITCHING

The μ PA572T is a super-mini-mold device provided with two MOS FET circuits. It achieves high-density mounting and saves mounting costs.

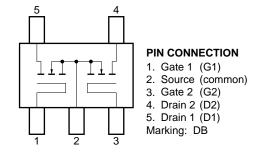
FEATURES

- Two source common MOS FET circuits in package the same size as SC-70
- Directly driven by 3 V power supply
- · Automatic mounting supported

PACKAGE DIMENSIONS (in millimeters)



EQUIVALENT CIRCUIT



ABSOLUTE MAXIMUM RATINGS (TA = 25 °C)

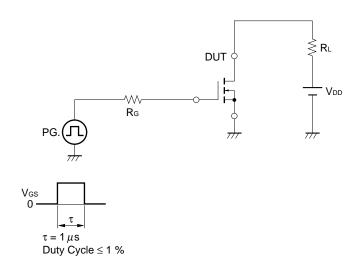
PARAMETER	SYMBOL	TEST CONDITIONS	RATINGS	UNIT
Drain to Source Voltage	VDSS	Ves = 0	30	V
Gate to Source Voltage	Vgss	V _{DS} = 0	±7	V
Drain Current (DC)	I _{D(DC)}		±100	mA
Drain Current (pulse)	ID(pulse)	PW ≤ 10 ms, Duty Cycle ≤ 50 %	±200	mA
Total Power Dissipation	Рт		200 (Total)	mW
Channel Temperature	Tch		150	°C
Operating Temperature	Topt		-55 to +80	°C
Storage Temperature	T _{stg}		-55 to +150	°C

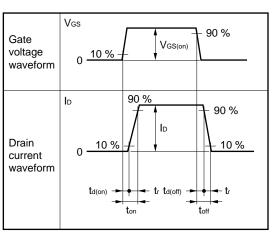


ELECTRICAL CHARACTERISTICS (TA = 25 °C)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain Cut-off Current	Ipss	V _{DS} = 30 V, V _{GS} = 0			1.0	μΑ
Gate Leakage Current	Igss	$V_{GS} = \pm 5 \text{ V}, V_{DS} = 0$			±3.0	μΑ
Gate Cut-off Voltage	V _{GS(off)}	$V_{DS} = 3 \text{ V}, \text{ ID} = 10 \mu \text{A}$	0.8	1.0	1.5	V
Forward Transfer Admittance	yfs	V _{DS} = 3 V, I _D = 10 mA	20	50		mS
Drain to Source On-State Resistance	RDS(on)1	V _G S = 2.5 V, I _D = 1 mA		7	13	Ω
Drain to Source On-State Resistance	RDS(on)2	V _G S = 4.0 V, I _D = 10 mA		5	8	Ω
Input Capacitance	Ciss	V _{DS} = 5.0 V, V _{GS} = 0, f = 1 MHz		16		pF
Output Capacitance	Coss			14		pF
Reverse Transfer Capacitance	Crss			2		pF
Turn-On Delay Time	td(on)	$V_{\text{DD}} = 5 \text{ V, ID} = 10 \text{ mA, V}_{\text{GS(on)}} = 5 \text{ V,}$ $R_{\text{G}} = 10 \Omega, \text{ RL} = 500 \Omega$		15		ns
Rise Time	tr			20		ns
Turn-Off Delay Time	t _{d(off)}			100		ns
Fall Time	t _f			100		ns

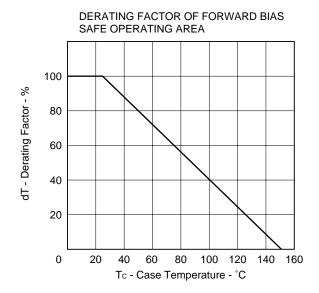
SWITCHING TIME MEASUREMENT CIRCUIT AND CONDITIONS (RESISTANCE LOADED)

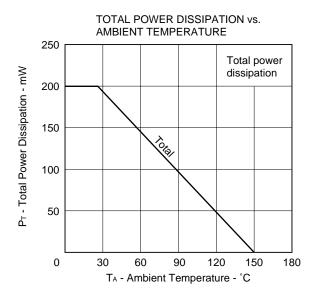


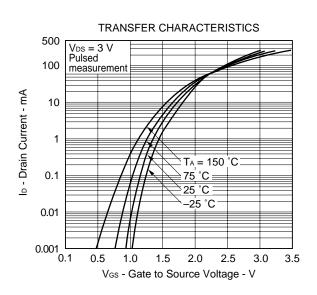


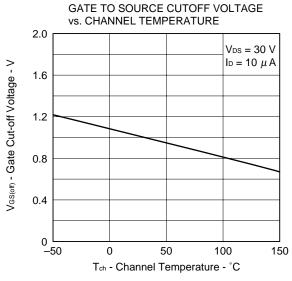


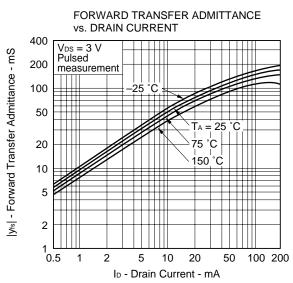
TYPICAL CHARACTERISTICS (TA = 25 °C)

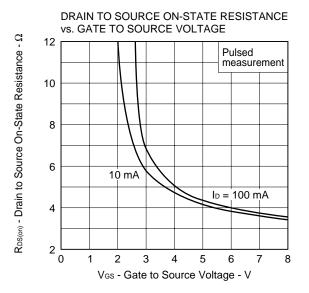




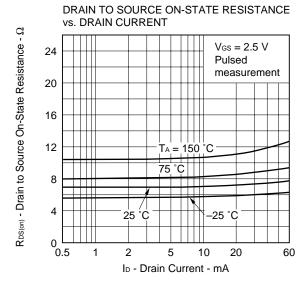


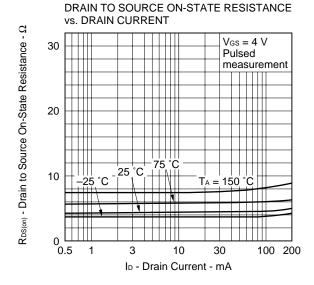


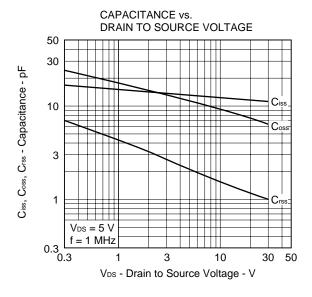


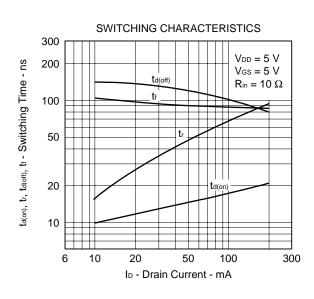


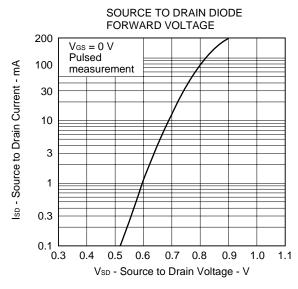


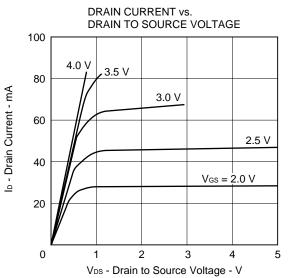














REFERENCE

Document Name	Document No.		
NEC semiconductor device reliability/quality control system	TEI-1202		
Quality grade on NEC semiconductor devices	IEI-1209		
Semiconductor device mounting technology manual	C10535E		
Guide to quality assurance for semiconductor devices	MEI-1202		
Semiconductor selection guide	X10679E		

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Anti-radioactive design is not implemented in this product.